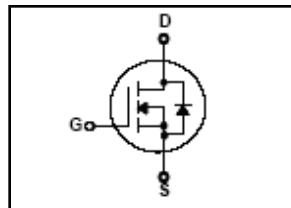
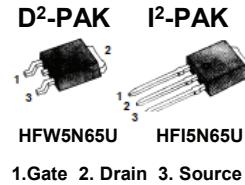


# HFW5N65U / HFI5N65U 650V N-Channel MOSFET

## FEATURES

- Originative New Design
- Superior Avalanche Rugged Technology
- Robust Gate Oxide Technology
- Very Low Intrinsic Capacitances
- Excellent Switching Characteristics
- Unrivalled Gate Charge : 10.5 nC (Typ.)
- Extended Safe Operating Area
- Lower  $R_{DS(ON)}$  : 2.3 Ω (Typ.) @  $V_{GS}=10V$
- 100% Avalanche Tested

$BV_{DSS} = 650\text{ V}$   
 $R_{DS(\text{on}) \text{ typ}} = 2.3\text{ }\Omega$   
 $I_D = 4.5\text{ A}$



## Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Value	Units
$V_{DSS}$	Drain-Source Voltage	650	V
$I_D$	Drain Current – Continuous ( $T_C = 25^\circ\text{C}$ )	4.5	A
	Drain Current – Continuous ( $T_C = 100^\circ\text{C}$ )	2.8	A
$I_{DM}$	Drain Current – Pulsed (Note 1)	18	A
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy (Note 2)	163	mJ
$I_{AR}$	Avalanche Current (Note 1)	4.5	A
$E_{AR}$	Repetitive Avalanche Energy (Note 1)	12.3	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ (Note 3)	4.5	V/ns
$P_D$	Power Dissipation ( $T_A = 25^\circ\text{C}$ ) *	3.13	W
	Power Dissipation ( $T_C = 25^\circ\text{C}$ ) - Derate above $25^\circ\text{C}$	123	W
		0.98	W/ $^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

## Thermal Resistance Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	1.02	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-Ambient*	--	40	
$R_{\theta JA}$	Junction-to-Ambient	--	62.5	

\* When mounted on the minimum pad size recommended (PCB Mount)

## Package Marking and Ordering Information

Device Marking	Week Marking	Package	Packing	Quantity	RoHS Status
HFW5N65U	YWWX	TO-263	Reel	800	Pb Free
HFW5N65U	YWWXg	TO-263	Reel	800	Halogen Free
HF15N65U	YWWX	TO-262	Tube	50	Pb Free
HF15N65U	YWWXg	TO-262	Tube	50	Halogen Free

## Electrical Characteristics $T_c=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### On Characteristics

$V_{GS}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	2.5	--	4.5	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 2.25 \text{ A}$	--	2.3	2.9	$\Omega$

### Off Characteristics

$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	650	--	--	V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$	--	0.6	--	$\text{V}/^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$	--	--	1	$\mu\text{A}$
		$V_{DS} = 520 \text{ V}, T_c = 125^\circ\text{C}$	--	--	10	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	--	--	$\pm 100$	nA

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	600	780	pF
$C_{oss}$	Output Capacitance		--	60	78	pF
$C_{rss}$	Reverse Transfer Capacitance		--	7.7	10	pF

### Switching Characteristics

$t_{d(on)}$	Turn-On Time	$V_{DS} = 325 \text{ V}, I_D = 4.5 \text{ A}, R_G = 25 \Omega$	--	22	44	ns
$t_r$	Turn-On Rise Time		--	40	80	ns
$t_{d(off)}$	Turn-Off Delay Time		--	45	90	ns
$t_f$	Turn-Off Fall Time		--	35	70	ns
$Q_g$	Total Gate Charge	$V_{DS} = 520 \text{ V}, I_D = 4.5 \text{ A}, V_{GS} = 10 \text{ V}$	--	10.5	13.5	nC
$Q_{qs}$	Gate-Source Charge		--	3.5	--	nC
$Q_{qd}$	Gate-Drain Charge		--	3	--	nC

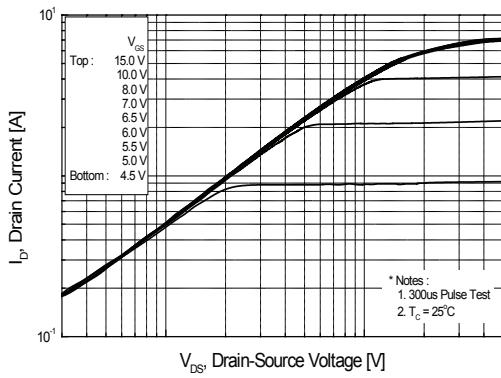
### Source-Drain Diode Maximum Ratings and Characteristics

$I_S$	Continuous Source-Drain Diode Forward Current	--	--	4.5	A	
$I_{SM}$	Pulsed Source-Drain Diode Forward Current	--	--	18		
$V_{SD}$	Source-Drain Diode Forward Voltage	$I_S = 4.5 \text{ A}, V_{GS} = 0 \text{ V}$	--	--	1.4	V
$trr$	Reverse Recovery Time	$I_S = 4.5 \text{ A}, V_{GS} = 0 \text{ V}$ $dI_F/dt = 100 \text{ A}/\mu\text{s}$	--	243	--	ns
$Qrr$	Reverse Recovery Charge		--	1.5	--	$\mu\text{C}$

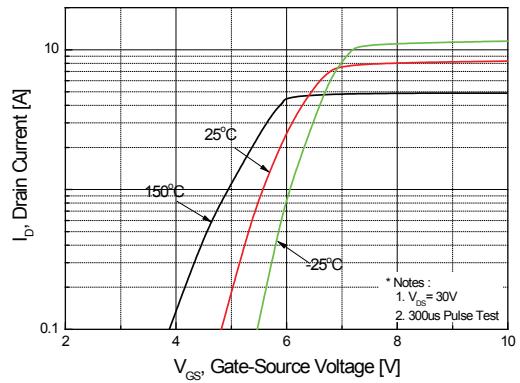
#### Notes :

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2.  $L=14.8\text{mH}$ ,  $I_{AS}=4.5\text{A}$ ,  $V_{DD}=50\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
3.  $I_{SD}\leq 4.5\text{A}$ ,  $di/dt\leq 200\text{A}/\mu\text{s}$ ,  $V_{DD}\leq BV_{DSS}$ , Starting  $T_J=25^\circ\text{C}$
4. Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
5. Essentially Independent of Operating Temperature

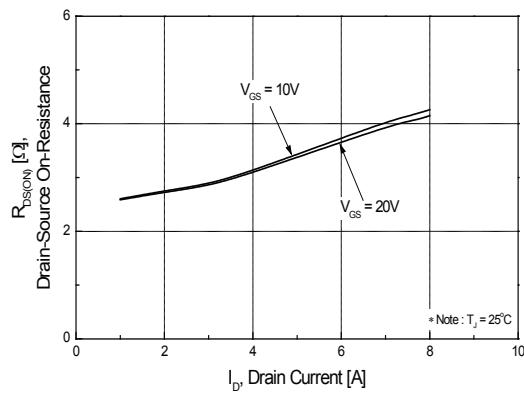
## Typical Characteristics



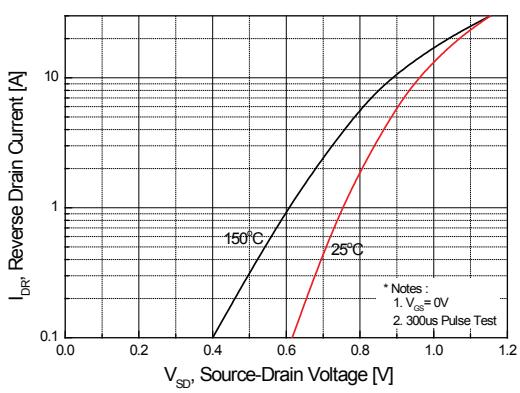
**Figure 1. On Region Characteristics**



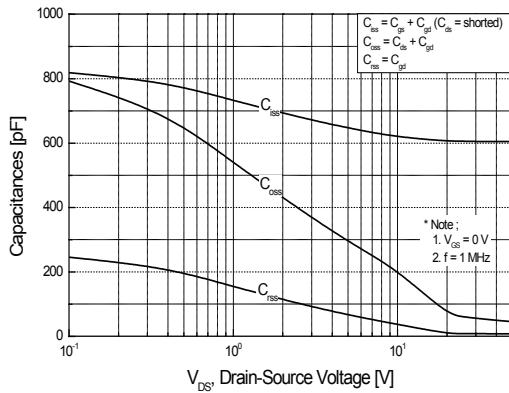
**Figure 2. Transfer Characteristics**



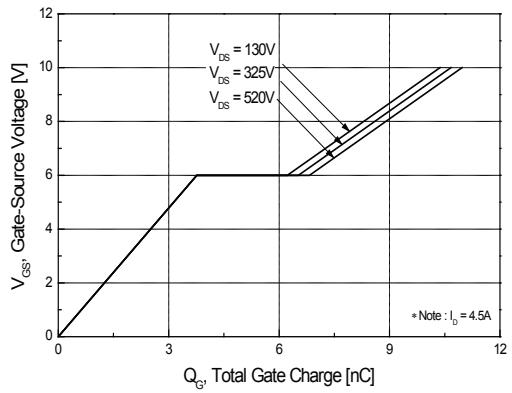
**Figure 3. On Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**

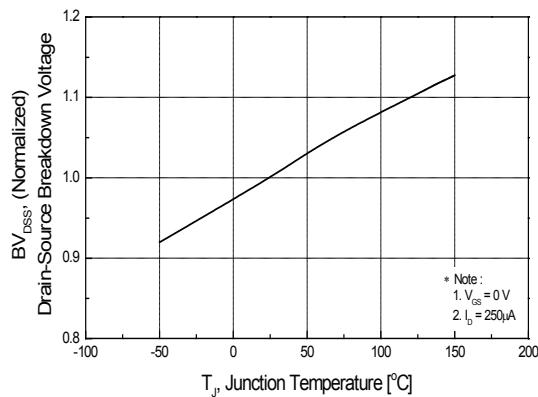


**Figure 5. Capacitance Characteristics**

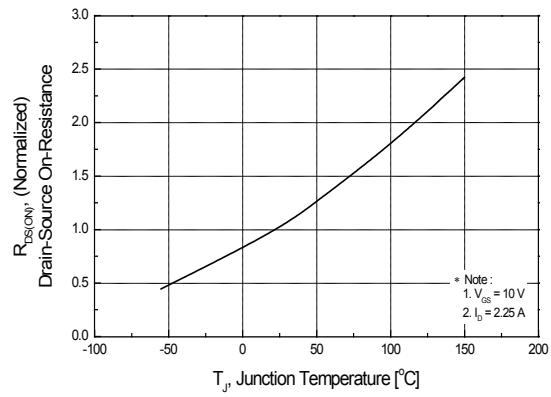


**Figure 6. Gate Charge Characteristics**

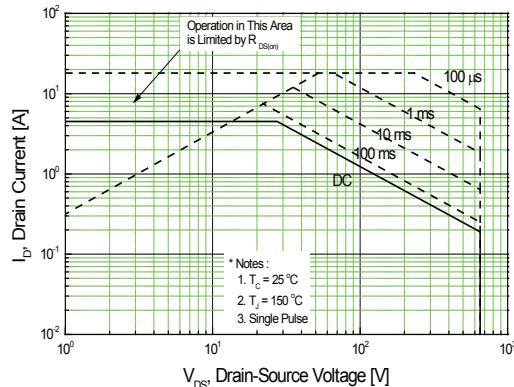
## Typical Characteristics (continued)



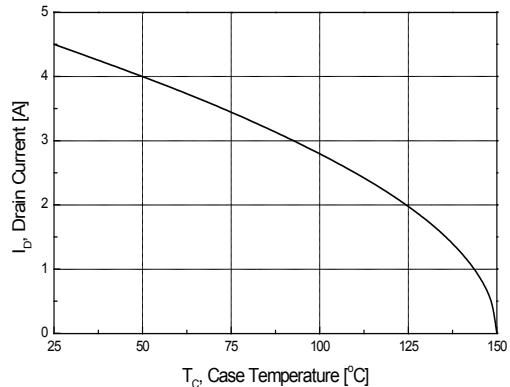
**Figure 7. Breakdown Voltage Variation vs Temperature**



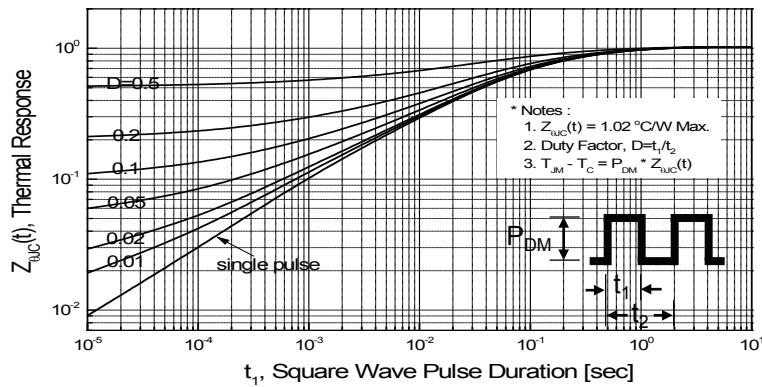
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs Case Temperature**



**Figure 11. Transient Thermal Response Curve**

Fig 12. Gate Charge Test Circuit & Waveform

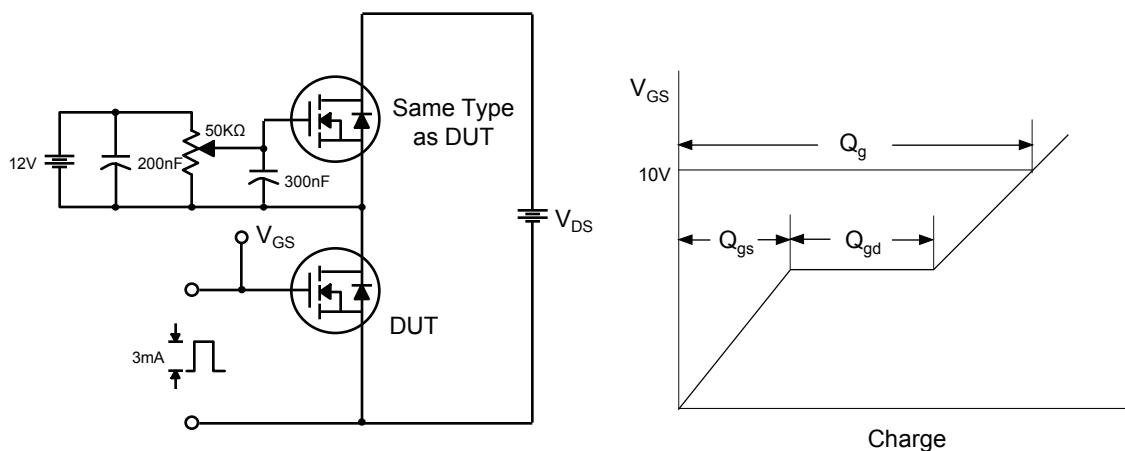


Fig 13. Resistive Switching Test Circuit & Waveforms

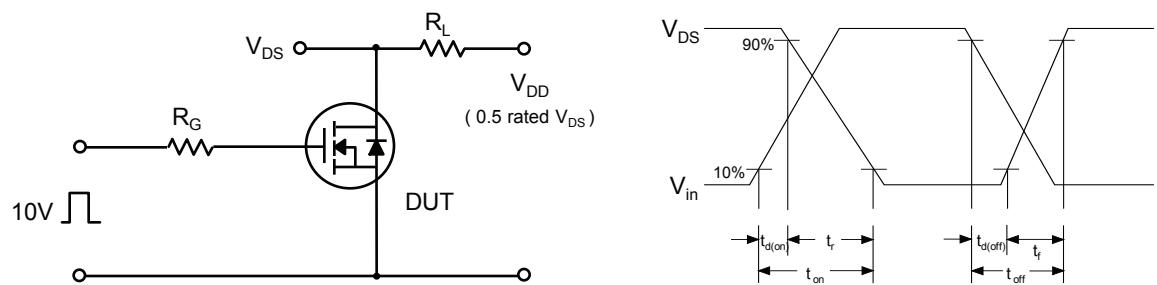


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

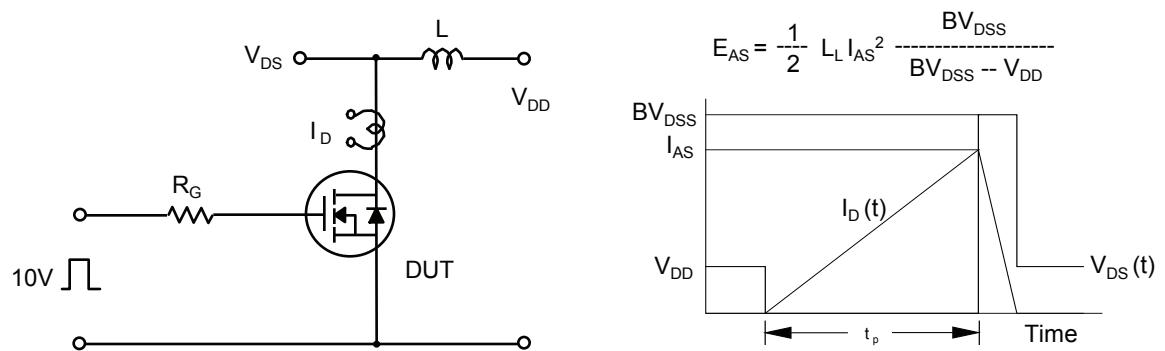
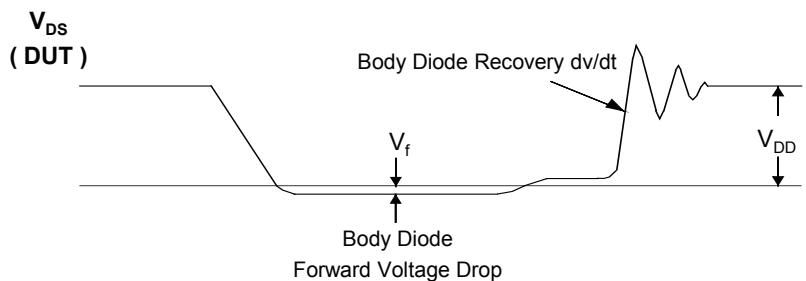
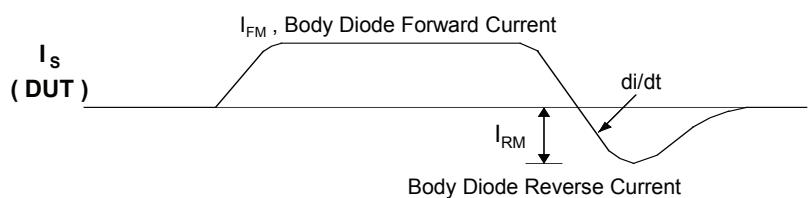
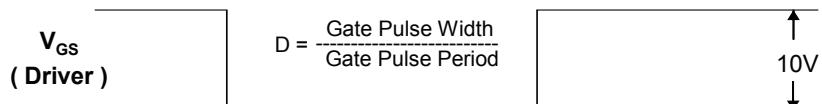
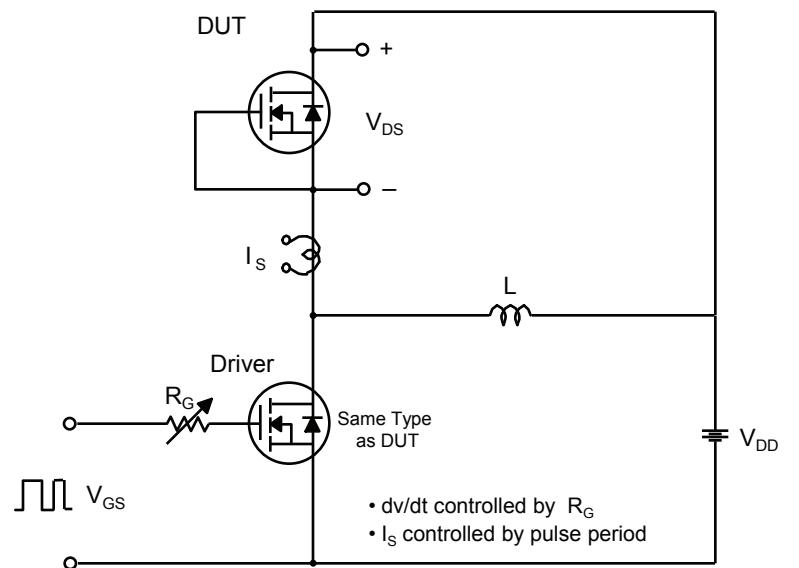
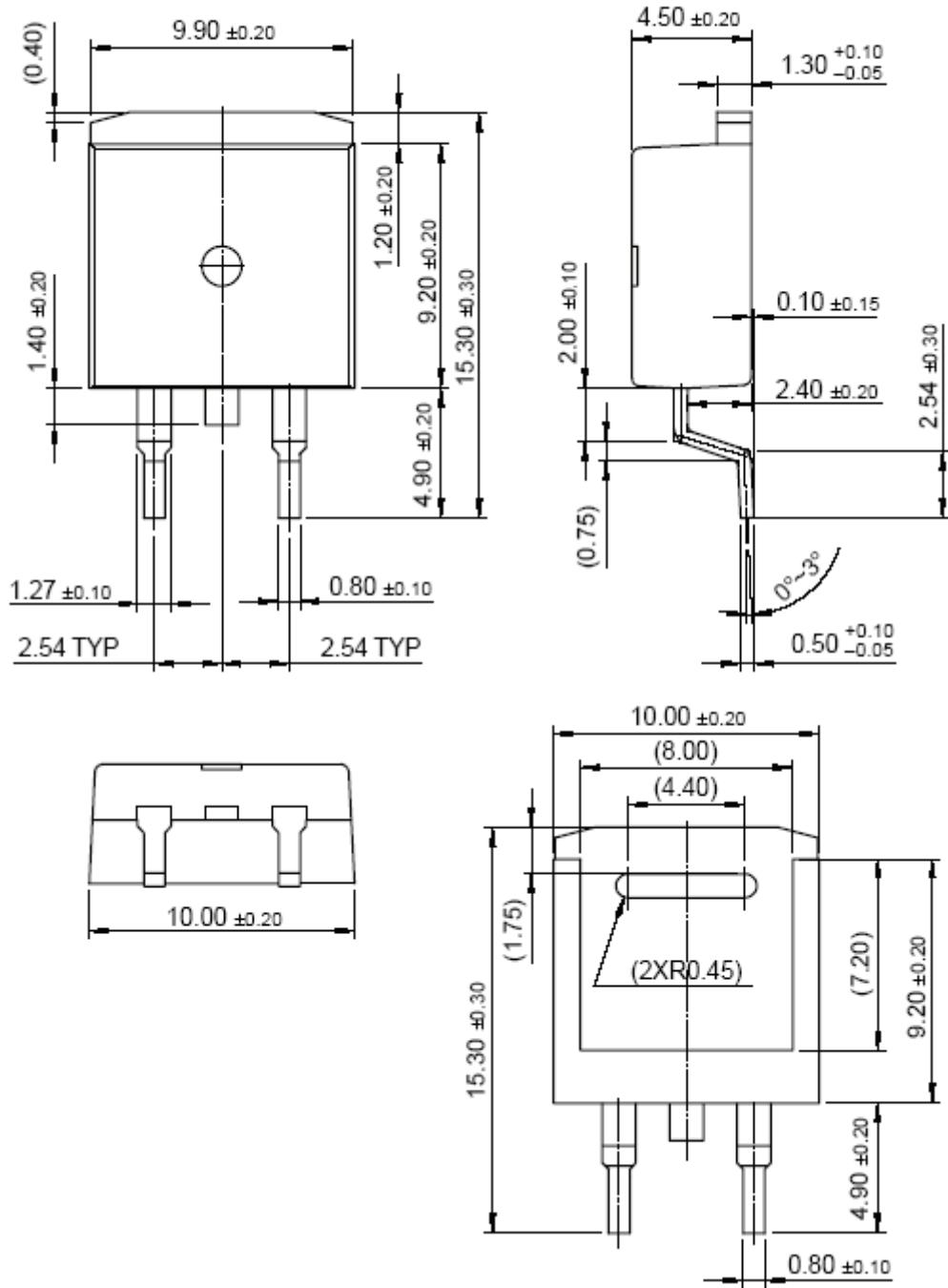


Fig 15. Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms



**Package Dimension****D<sup>2</sup>PAK**

**Package Dimension****I<sup>2</sup>PAK**